

PhD defense:

Quantum Thermal Transport in Semiconductor Nanostructure with Diffusion

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- Methodology
- Thermal Transport in Homogeneous Structure
- Thermal Transport in Heterostructure
- Transport with Electron-Phonon Coupling









Motivation for Thermal Transport







Increasing power density a great concern in downscaling trends

Question1: Why are we interested in the heat transfer?



Application of thermoelectric device



 $ZT = S^2 \sigma T / \kappa$

Low thermal conductivity is critical to enhance the performance of thermoelectric device.





High thermal conductivity is needed.

Low thermal conductivity is needed.



The thermal transport should be modeled accurately.





Challenges of device level simulations



Complicated systems

- Complicated geometries
- Multiple materials
- Strain/Relaxation
- ➤ Interfaces
- Boundary confinement
- Challenging simulation domain

D. Sacchetto et. al. Proceedings of the IEEE, Volume: 100, Issue: 6, June 2012

Atomistic model to target complicated systems is necessary for realistic device modeling.





Thermal transport: from academia to industry





Devices are now in sub-20nm regime→ Quantum treatment of heat flow: Phonon transport



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Phonon frequency ω and wave vector $k \rightarrow$ Phonon dispersion

Phonon transport includes two parts: Non-equilibrium Green's function and Bose-Einstein distribution.

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Thermal transport calculations in real devices/materials

Question: Is it enough to have a correct phonon dispersion?

Thermal conductivity extraction:

$$\kappa = \frac{I_Q \cdot L}{\Delta T \cdot S}$$

This equation fails in the ballistic case! →Phonon scattering model is needed

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R.Berman, *Thermal conduction in Solids*, Clarendon, Oxford, 1974.

Need to capture the behaviors of thermal conductivity

Proper phonon scattering model should be chosen. Keyword: scattering.



Temperature analysis should be included



R. Venugopal et al. J. Appl. Phys., Vol. 93, No. 9, 2003



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NEUTROPY ingredients for a good heat transport model Four provinterface, scattering, temperature, and efficient



Question: Can we find a method that can balance all these 5 aspects?







Introduction of Quantum Thermal Transport









	Quantum	Interface	Scattering	Temperature	Efficient
DMM	×	\checkmark	×	×	\checkmark
BTE	×	\checkmark	\checkmark	\checkmark	\checkmark
MD	×	\checkmark	\checkmark	\checkmark	×
GF(Anharmonic)	\checkmark	\checkmark	\checkmark	×	×
Landauer	\checkmark	×	\checkmark	×	\checkmark

DMM: Diffusive mismatch model; **BTE**: Boltzmann transport equation; **MD**: Molecular dynamics; **Laudauer** approach: Landauer approach with full dispersion **GF(Anharmonic)**: Green's function with anharmonic phonon-phonon scattering

Quantum transport models are our main interest.







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with anharmonic phonon-phonon scattering



Anharmonic phonon-phonon scattering is described. But there is one problem.



VFF + NEGF

NEM 55 thermal transport calculation deviating from the experimental result

Conventional phonon scattering theory predicts a T^3 dependence for thermal conductance in low temperature



Our calculation is consistent with the experimental result in the low temperature.
 The contradiction in the higher temperature needs scattering models.

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phonon scattering mechanisms should be considered for correct physical meanings

Dominant scatterings profile



M.G. Holland, et. al, Proc. Int. Conf. Physics of Semiconductors, Exeter, England, 474 (1962)

Multiple phonon scattering mechanisms should be included. Question: How to choose different phonon scattering?







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Phonon scattering models: Relaxation time approximation model

is given by

$$I_{Q} = \frac{1}{h} \int_{-\infty}^{+\infty} dE \left(\Xi_{ph} M_{ph} \right) E \left(f_{BE}^{1} - f_{BE}^{2} \right)$$
$$\Xi_{ph} = \lambda_{ph} (E) / \left(L + \lambda_{ph} (E) \right)$$

C. Jeong, S. Datta, and M. Lundstrom, J. Appl. Phys. 111, 093708 (2012).

Phonon scattering mechanisms in BTE model:

1. Phonon grain boundary scattering:

$$\tau_b^{-1} = v_s / LF$$

Phonon mean free path $\lambda_{nh}(E)$

 $\lambda_{ph}(E) = \langle v_s \rangle \cdot \tau_p$

2. Phonon impurity scattering: (mass difference)

$$\tau_{IM}^{-1} = B\omega^4$$

3. Phonon-phonon scattering: $\tau_{p-p}^{-1} = C\omega^2 T^{\alpha}$ (Umklapp process) *Matthiessen rule:* $\tau_p^{-1} = \tau_b^{-1} + \tau_{IM}^{-1} + \tau_{p-p}^{-1}$

M. G. Holland, Phys. Rev. 132, 2461 (1963).

Different RTA models can describe the scatterings in the phonon transport.



Com SA models, GF, with phonon Büttiker probe

device S contact D contact Retarded Green's function is: *P-1 P P+1* $G^{r}(E) = \frac{1}{E^{2} - D - \Sigma^{BP}(E) - \Sigma^{R}_{contact}(E)}$ P-1 P S contact $\sum_{i=1}^{R}$ D contact Scattering self energy $2i \cdot E$ (E)P-2P-1 2 Here, $\tau_p^{-1} = \tau_b^{-1} + \tau_{IM}^{-1} + \tau_{p-p}^{-1}$ Virtual contact (Büttiker probe)

RTA models are connected with Green's function through the Virtual contact concept: Büttiker probe (BP).









Successfully covering all 5 key ingredients







Thermal Transport Study in Homogeneous Structure







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Successful benchmark of thermal conductivity <u>for Si and Ge</u>

Phonon scattering mechanism in BTE transport:

1. Phonon grain boundary scattering

 τ_b^{-1} is from ref. 1.

2. Phonon impurity scattering (mass difference) -1 P 4

$$\tau_{IM}^{-1} = B\omega^4$$

 Phonon-phonon scattering (Umklapp process)

$$\tau_{p-p}^{-1} = C\omega^2 T^{\alpha}$$

Matthiessen rule:

$$\tau_{p}^{-1} = \tau_{b}^{-1} + \tau_{IM}^{-1} + \tau_{p-p}^{-1}$$
Material $B(s^{3})$ $C(sK^{-\alpha})$ α
Si 0.71×10^{-45} $\frac{1.74 \times 10^{-2}}{1}$ 1.64
Ge 3.2×10^{-45} 1.12×10^{-2} 1.48



Thermal properties are matched well with experimental results.





Extraction of local temperature

Average phonon gas energy

 $E\uparrow 2 \ G\uparrow < (E)dE \approx \int \uparrow E\uparrow 2 \ A/e\uparrow E/k\downarrow B \ T\downarrow local -1 \ dE.$









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Phonon scattering models: elaxation time approximation(RTA) model

Phonon scattering mechanisms in BTE model:

 $\tau_{b}^{-1} = v_{s} / LF$ 1. Phonon boundary scattering: $\tau_{IM}^{-1} = B\omega^4$ 2. Phonon impurity scattering: 1. Bulk (mass difference) 3. Phonon-phonon scattering: $\tau_{p-p}^{-1} = C\omega^2 T^{\alpha}$ (Umklapp process) *Matthiessen rule:* $\tau_p^{-1} = \tau_b^{-1} + \tau_{IM}^{-1} + \tau_{p-p}^{-1}$ K. Miao, Appl. Phys. Lett. 108, 113107 (2016); $\tau_{h}^{-1} = v_{s} / d$ Phonon boundary scattering: 2. UTB R. Cheaito et al, PRL 109, 195901 (2012)

Different RTA models can describe the scatterings in the phonon transport.





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Thermal conductivity for bulk Ge



For Ge bulk structure, phonon-phonon scattering is the dominant scattering mechanism when K>20K.





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Thermal conductivity for Ge UTB







- 1. First apply the NEGF+Buettiker probe model to solve the phonon transport.
- 2. Thermal conductivity and mean free path are calculated and benchmarked with experimental data.
- 3. Show the method to extract the local temperature in the device. Understand the relation between scattering and temperature drop.
- 4. Show the scattering-dominating picture in the whole temperature range.
- 5. Compare the difference of thermal transport between bulk and UTB.



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Thermal Transport Study in Heterostructure









Nano Lett., Vol. 7, No. 4, 2007

	Silicide	Formation temperature (°C)	Resistivity (μΩ·cm)	Silicon consumed (Å) per Å of metal	Resulting silicide thickness (Å) per Å of metal	Φ _b on n-type
Preferred silicides for						(01)
applications are PtSi2,TiSi2,	TiSi ₂	800-900	13-16	2.27	2.51	0.6
NiSi and CoSi2 due to their	CoSi ₂	600-700	18-20	3.64	3.52	0.64
overall excellent properties.	PtSi	300-600	28-35	1.32	1.97	0.87
	NiSi	400-600	14-20	1.83	2.34	0.7

S. P. Murarka, Silicides for VLSI Applications, London: Academic press, 1983.













Thermal conductance drop is mainly caused by the interface phonon mismatch.



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Relaxation increases the thermal conductance \rightarrow Using VFF model gives a same conductance enhancement as by using DFT model.





Limitations of the classical Landauer treatment



C. Gang, et al. Microscale Thermophysical Engineering, 5:71–88, 2001

$$Q = \frac{1}{(2\pi)^3} \int \sum_{v} h\omega u_z \alpha_{L \to R} [f_{BE}(\omega, T_L) - f_{BE}(\omega, T_R)] d(h\omega)$$

1. Emitted phonon at the interface is out of equilibrium.

2. Local equivalent equilibrium temperatures are redefined.

3. Incorrect result of a nonzero thermal interface resistance is predicted in homogeneous structure.

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Landauer formula with NEGF

Landauer formula with NEGF:

$$\begin{split} &I \overline{\downarrow} left = \int -\infty \uparrow +\infty \overline{\sum} j = 1, j \neq i \uparrow N \downarrow A \overline{\lim} \sum n = 1, n \neq m \uparrow 3 \overline{\lim} 1/h \ E[T \downarrow left, right (E)(1/e^{\uparrow} E/k \downarrow B \\ T \downarrow right \ -1 \ -1/e^{\uparrow} E/k \downarrow B \ T \downarrow left \ -1 \) + T \downarrow (i,m) left \ (E)(1/e^{\uparrow} E/k \downarrow B \ T \downarrow i.m \ -1 \ -1/e^{\uparrow} E/k \\ k \downarrow B \ T \downarrow left \ -1 \)] dE \end{split}$$

$$\begin{split} I_{right} &= -I_{left} \\ \text{If there is no scattering, } \mathcal{T}\downarrow(i,m) left \text{ is 0, which gives:} \\ I\downarrow left &= \int -\infty \uparrow +\infty \iiint \sum_{j=1, j\neq i} N\downarrow A \ggg \sum_{n=1, n\neq m} \gamma 3 \ggg 1/h E[\mathcal{T}\downarrow left, right (E)(1/e\uparrow E/k\downarrow B)] dE \\ \mathcal{T}\downarrow right -1 -1/e\uparrow E/k\downarrow B \ \mathcal{T}\downarrow left -1 \)] dE \end{split}$$

_andauer formula with traditional treatment:

$$Q = \frac{1}{(2\pi)^3} \int \sum_{i} h \omega u_z a_{L \to R} [f_{BE}(\omega, T_L) - f_{BE}(\omega, T_R)] d(h\omega)$$

C. Gang, et al. Microscale Thermophysical Engineering, 5:71-88, 2001

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Landauer formula with quantum NEGF and scattering



PU Interface resistance can be neglected.



ΙΤΥ

DOS at Si(30)/Si(28) interface



Mass difference will affect the phonon dispersion dramatically, hence the interface interference DOS appears.



Temperature profile inside the device







1. Different scattering rate will cause different temperature drops inside the device.

2. With the small scattering, dispersion mismatch causes the temperature drop at the interface. This effect decays with larger scattering rate.





Energy resolved current and DOS





Energy resolved phonon current & Phonon density of states

Colorful contour plot is the energy resolved phonon current in Si/Ge heterostructure. Contour line is the phonon density of states inside the device.



Quantum mechanism is considered with the application of NEGF+Büttiker probe.
 NEMO5 is capable to understand the phonon transport more straightforward.







Interface resistance extraction









Extraction of interfacial thermal resistance





Comparison of interface thermal resistance with MD



A significant difference between NEMD and NEGF is noticed.
1. NEMD needs a large structure to predict the thermal transport in bulk.

2. NEMD needs a large time steps to achieve conserved transport results.







Ref.1: E. S. Landry and A. J. H. McGaughey Phys. Rev. B **80**, 2009 Experimental: Superlattices and Microstructures, Vol. 28, No. 3, 2000







- 1. Include the process of relaxation calculation in the heterostructure.
- 2. Show the capability of this work to solve phonon transport of interface problem.
- 3. Intrinsic scattering is not the main reason for the interface resistance. The mismatch of phonon dispersion is!
- 4. Interfacial thermal resistance is largely independent on the intrinsic scatterings.
- 5. Variance between our model and other models are explored.









Transport Study with Electron-Phonon Coupling









Different temperatures in the device





Temperature-driven electron flow

Thermoelectric generator



Seebeck effect: electron current is generated by temperature.

Electron-phonon coupling



Electron is coupled with phonon inside the device/materials.

Electron and phonon transport with coupling due to temperature difference should be understood.





Electron-phonon coupling model



NEMO5 can couple electron and phonon transport inside the device to do the electronic and thermal analysis.



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Electron transport:

1.Tight-binding model (**10 bands** model) 2.NEGF+Büttiker probe

Phonon transport:

- 1. Valence force field model (3 bands model)
- 2. NEGF+Büttiker probe

One probe is attached for each atom for both electron and phonon case.







Effect of including e-p coupling





Energy conservation check





NEMO5 implementation

Energy dependent models are added into NEMO5.

absorption

1. Scattering rates

Acoustic phonon scattering

$$\dot{\gamma}_{e-p,\mathrm{A}} = \frac{\pi \varphi_{d,\mathrm{A}}^2 k_\mathrm{B} T_p D_e [E_e(\boldsymbol{p}_e)]}{\hbar \rho u_{p,\mathrm{A}}^2}$$

Optical phonon scattering

$$\begin{aligned} \tau_{e^-p,O}^{-1} &= \frac{\varphi_{d,O}^{\prime 2} f_p^{\circ}(\omega_{p,O}) m_{e,e}^{3/2} [E_e(p) + \hbar \omega_{p,O}]^{1/2}}{2^{1/2} \pi \hbar^3 \rho \omega_{p,O}}, \\ \text{emission} \\ \tau_{e^-p,O}^{-1} &= \frac{\varphi_{d,O}^{\prime 2} [f_p^{\circ}(\omega_{p,O}) + 1] m_{e,e}^{3/2} [E_e(p) - \hbar \omega_{p,O}]^{1/2}}{2^{1/2} \pi \hbar^3 \rho \omega_{p,O}}, \end{aligned}$$

2. Relation between scattering rate and self energy

$$\gamma(\vec{k}_{\parallel}, E) = -\frac{4}{\hbar} \mathrm{Im} \left[\left(\Sigma_{BP}^{R}(\vec{k}_{\parallel}, E) \right) \right]$$







Scattering mechanisms



Here, the acoustic and optical phonon scattering are considered.











 More electron temperature drops in Si and Ge region compared to phonon case.
 More phonon temperature drops at the Si/Ge interface.





Preliminary result about the energy exchange inside the device:



Here is dissipated in the drain side. In future, we will apply our method in real large device to capture the self-heating effect.













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Prof. Ruan, Prof. R. Rahman, Prof. Dr. J. Huang, Dr. J. Fonseca, Dr. B. Novakovic, Dr. C. Bowen, Dr. P. Sengupta, Dr. M. Salmani, Dr. M. Luisier, Dr. G. Hegde, Dr. S. Park, Dr. L. Zeng, Dr. A. Paul, Dr. S. Lee, Dr. H. Ryu, Dr. Y. Tan, Dr. Z. Jiang, Dr. Y. He., Dr. S. Sadasivam, Dr. X. Wang and Dr. Y. Gao.

Thank you to the entire Klimeck research group.

NCN Staff members: V. Johnson, C. Heins, L. Schumacher, A. Byrne, A. Buckles



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Thanks!



